



ELECTRONICS, INC.  
44 FARRAND STREET  
BLOOMFIELD, NJ 07003  
(973) 748-5089  
<http://www.nteinc.com>

**NTE2996  
MOSFET  
N-Channel, Enhancement Mode  
High Speed Switch**

**Features:**

- Ultra Low On-Resistance
- Dynamic dv/dt Rating
- +175°C Operating Temperature
- Fast Switching
- Fully Avalanche Rated

**Absolute Maximum Ratings:**

Drain Current, $I_D$	
Continuous ( $V_{GS} = 10V$ )	
$T_C = +25^\circ C$ (Note 1)	..... 84A
$T_C = +100^\circ C$ .....	..... 59A
Pulsed (Note 2) .....	..... 330A
Total Power Dissipation ( $T_C = +25^\circ C$ ), $P_D$ .....	..... 200W
Derate Above $25^\circ C$ .....	..... $1.4W/^\circ C$
Gate-Source Voltage, $V_{GS}$ .....	..... $\pm 20V$
Single Pulsed Avalanche Energy ( $I_{AS} = 50A$ , $L = 260\mu H$ , Note 3), $E_{AS}$ .....	..... 320mJ
Avalanche Current (Note 2), $I_{AR}$ .....	..... 50A
Repetitive Avalanche Energy (Note 2), $E_{AR}$ .....	..... 17mJ
Peak Diode Recovery dv/dt (Note 4), dv/dt .....	..... 4.0V/ns
Operating Junction Temperature Range, $T_J$ .....	..... $-55^\circ$ to $+175^\circ C$
Storage Temperature Range, $T_{stg}$ .....	..... $-55^\circ$ to $+175^\circ C$
Maximum Lead Temperature (During Soldering, 1.6mm from case, 10sec), $T_L$ .....	..... $+300^\circ C$
Maximum Thermal Resistance:	
Junction-to-Case, $R_{thJC}$ .....	..... $0.75^\circ C/W$
Junction-to-Ambient, $R_{thJA}$ .....	..... $62^\circ C/W$
Typical Thermal Resistance, Case-to-Sink (Flat, greased surface), $R_{thCS}$ .....	..... $0.50^\circ C/W$

Note 1. Calculated continuous current based on maximum allowable junction temperature. Package limitation current is 75A.

Note 2. Repetitive Rating: Pulse width limited by maximum junction temperature.

Note 3. This is a calculated value limited to  $T_J = +175^\circ C$ .

Note 4.  $I_{SD} \leq 50A$ ,  $di/dt \leq 230A/\mu s$ ,  $V_{DD} \leq V_{(BR)DSS}$ ,  $T_J \leq +175^\circ C$ .

**Electrical Characteristics:** ( $T_J = +25^\circ\text{C}$  unless otherwise specified)

Parameter	Symbol	Test Conditions	Min	Typ	Max	Unit
Drain-Source Breakdown Voltage	$\text{BV}_{\text{DSS}}$	$V_{\text{GS}} = 0\text{V}, I_D = 250\mu\text{A}$	60	-	-	V
Breakdown Voltage Temperature Coefficient	$\Delta V_{(\text{BR})\text{DSS}} / \Delta T_J$	Reference to $+25^\circ\text{C}$ , $I_D = 1\text{mA}$	-	0.064	-	$\text{V}/^\circ\text{C}$
Static Drain-Source ON Resistance	$R_{\text{DS}(\text{on})}$	$V_{\text{GS}} = 10\text{V}, I_D = 50\text{A}$ , Note 5	-	-	12	$\text{m}\Omega$
Gate Threshold Voltage	$V_{\text{GS}(\text{th})}$	$V_{\text{DS}} = V_{\text{GS}}, I_D = 250\mu\text{A}$	2.0	-	4.0	V
Forward Transconductance	$g_{\text{fs}}$	$V_{\text{DS}} = 25\text{V}, I_D = 50\text{A}$ , Note 5	69	-	-	mhos
Drain-to-Source Leakage Current	$I_{\text{DSS}}$	$V_{\text{DS}} = 60\text{V}, V_{\text{GS}} = 0$	-	-	25	$\mu\text{A}$
		$V_{\text{DS}} = 48\text{V}, V_{\text{GS}} = 0\text{V}, T_C = +150^\circ\text{C}$	-	-	250	$\mu\text{A}$
Gate-Source Leakage, Forward	$I_{\text{GSS}}$	$V_{\text{GS}} = 20\text{V}$	-	-	100	nA
Gate-Source Leakage, Reverse		$V_{\text{GS}} = -20\text{V}$	-	-	-100	nA
Total Gate Charge	$Q_g$	$V_{\text{GS}} = 10\text{V}, I_D = 50\text{A}, V_{\text{DS}} = 48\text{V}$	-	-	130	nC
Gate-Source Charge	$Q_{\text{gs}}$		-	-	28	nC
Gate-Drain ("Miller") Charge	$Q_{\text{gd}}$		-	-	44	nC
Turn-On Delay Time	$t_{\text{d}(\text{on})}$	$V_{\text{DD}} = 30\text{V}, I_D = 50\text{A}, R_G = 3.6\Omega, V_{\text{GS}} = 10\text{V}$ , Note 5	-	12	-	ns
Rise Time	$t_r$		-	78	-	ns
Turn-Off Delay Time	$t_{\text{d}(\text{off})}$		-	48	-	ns
Fall Time	$t_f$		-	53	-	ns
Internal Drain Inductance	$L_D$	Between lead, 6mm (0.25") from package and center of die contact	-	4.5	-	nH
Internal Source Inductance	$L_S$		-	7.5	-	nH
Input Capacitance	$C_{\text{iss}}$	$V_{\text{GS}} = 0\text{V}, V_{\text{DS}} = 25\text{V}, f = 1\text{MHz}$	-	3210	-	pF
Output Capacitance	$C_{\text{oss}}$		-	690	-	pF
Reverse Transfer Capacitance	$C_{\text{rss}}$		-	140	-	pF
<b>Source-Drain Diode Ratings and Characteristics</b>						
Continuous Source Current	$I_S$	(Body Diode) Note 6	-	-	84	A
Pulse Source Current	$I_{\text{SM}}$	(Body Diode) Note 2	-	-	330	A
Diode Forward Voltage	$V_{\text{SD}}$	$T_J = +25^\circ\text{C}, I_S = 50\text{A}, V_{\text{GS}} = 0\text{V}$ , Note 5	-	-	1.3	V
Reverse Recovery Time	$t_{\text{rr}}$	$T_J = +25^\circ\text{C}, I_F = 50\text{A}, di/dt = 100\text{A}/\mu\text{s}$ , Note 5	-	73	110	ns
Reverse Recovery Charge	$Q_{\text{rr}}$		-	220	330	$\mu\text{C}$
Forward Turn-On Time	$t_{\text{on}}$	Intrinsic turn-on time is neglegible (turn-on is dominated by $L_S + L_D$ )				

Note 2. Repetitive Rating: Pulse width limited by maximum junction temperature.

Note 5. Pulse Width  $\leq 400\mu\text{s}$ , Duty Cycle  $\leq 2\%$ .

Note 6. Calculated continuous current based on maximum allowable junction temperature. Package limitation current is 75A.

